Random bad cell map for wafer 82 s/n: Y21316-12-11 (not backplated)

Date: 04/09/99

		0		6				
		0	0			0		
	0	0				1		
	0	0	0		5		0	
	0	0	0	1		0	13	0
0	105	10	22	32		0	0	0
0	0			39	36	0	0	0
8	0	10	50	69	66	1	0	
0		10	149		37	0	0	
0		14		18	36	2	0	
		7	41	25	13	0	0	0
13	0	0	65	27	6		0	0
0	0	1	6	23		0		4
0	0	0	0	3	0	0	0	0
	0	0		0	0	0	0	
	0	0		0	0	0	0	
				0	0	0		
			4		13			

#	Number of bad cells in random locations
	No info